

Search Notes

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Examiner

PAUL T. CHIN

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

3652

SEARCHED

Class	Subclass	Date	Examiner
updated	search	8/14/2006	PTC

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR